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Article

# <sup>1</sup> Peculiar Magnetic and Transport Properties of CuFeS<sub>2</sub>: Defects Play <sup>2</sup> a Key Role

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15 ferromagnetism both in the Cu- and Fe-sublattice. This new view

16 opens up space for further investigations and applications of charge transfer compounds.

## 1. INTRODUCTION

<sup>17</sup> Chalcopyrite, CuFeS<sub>2</sub>, has been recognized as the world's most <sup>18</sup> important and most abundant copper ore for a thousand years. <sup>19</sup> Its unique electrical, magnetic, thermal, and optical properties <sup>20</sup> have already attracted attention from scientists since the dawn <sup>21</sup> of the semiconductor era.<sup>1-9</sup> Owing to these properties, <sup>22</sup> CuFeS<sub>2</sub> has been widely studied for its potential utilization in <sup>23</sup> photovoltaics,<sup>10</sup> spintronics,<sup>11</sup> and thermoelectrics.<sup>12-16</sup>

CuFeS<sub>2</sub>, crystallizing in a tetragonal structure with space 24 25 group  $I\overline{4}2d$ ,<sup>17</sup> is an antiferromagnetic (AFM) semiconductor <sub>26</sub> with a comparatively high Neel temperature  $(T_{\rm N} = 823 \text{ K}^5)$ 27 that can be understood in terms of very low anion-cation 28 charge-transfer energy facilitating the AFM order.<sup>18,19</sup> For the 29 complexity of its nature, CuFeS<sub>2</sub> has been the subject of 30 theoretical and experimental investigations for more than a 31 century.<sup>20</sup> Nevertheless, experimental investigations have been 32 hindered by its tendency to undergo decomposition or a phase 33 transition leading to the formation of extraneous phases.<sup>21,22</sup> 34 One of the most striking points for this material is the number 35 of unpaired electrons of iron and its ground state in relation to 36 the magnetic and spectroscopic properties.<sup>18,19,23</sup> Nevertheless, 37 there are many points that have yet to be explained. Namely, 38 Mössbauer spectroscopy shows the undoubted presence of 39 trivalent high-spin iron in the chalcopyrite structure,<sup>24</sup> 40 indicating five unpaired electrons in the d orbitals of Fe. In 41 contrast, a considerably lower magnetic moment is reported  $^{42}$  based on neutron diffraction,  $^{4,22}$  X-ray emission spectrosco- $^{43}$  py,  $^{19,23}$  and theoretical calculations.  $^{25-28}$  However, most of the 44 calculations combined with spectroscopy techniques neglect Fe

d-band dispersion and treat the Fe ions as impurities within an 45 anion-hosting band structure.<sup>18,19,23</sup> 46

The exact valence state of copper ions remains in debate, 47 although it is clear that number of d electrons is slightly lower 48 than 10, which would correspond to the Cu<sup>+1</sup> state.<sup>22,29,30</sup> The 49 electrical transport complexity is documented by a rather wide 50 range of reported band-gap values derived from various 51 experiments (i.e., 0.33  $eV_{,}^{31}$  0.53  $eV_{,}^{3}$  and 2.6  $eV_{,}^{5}$ ). 52 Furthermore, the electron mobility spans a rather wide range 53 from  $10^{-3}$  to  $10^2$  cm<sup>2</sup> V<sup>-1</sup> s<sup>-1</sup> depending on the temperature 54 and doping and Fermi level  $(E_{\rm F})$ . Thus, the nature of the ss electrical transport can be described within various models 56 starting with hopping transport in the low-temperature region 57 and, inevitably, ending with band transport at higher 58 temperatures. Some peculiar interactions have been included 59 to account for the "mysterious behaviour"23 of chalcopyrite 60 including negative charge transfer (CT) energy. The 61 contribution of CT-driven hybridization between the Fe3d 62 and S3p orbitals has also been discussed previously.<sup>19</sup> 63 Furthermore, band calculations can shed more light on the 64 delocalized Fe3d electrons,<sup>26,32,33</sup> thus attributing markedly to 65 a consistent picture as for the spectroscopic properties and 66 AFM ordering. However, the magnitude of the free-carrier 67

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68 mobility ( $\approx 100 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ ) observed in the present paper 69 and ref 34 is in contrast with the electron mobility within the 70 AFM order of CuFeS<sub>2</sub>. Thus, we miss a clue for the true 71 mechanism of charge transport in pristine and doped 72 chalcopyrite, although the spectroscopic and magnetic proper-73 ties may be addressed properly.

74 In addition, over the past decade, CuFeS<sub>2</sub> has been the 75 subject of extensive research as for its potential in thermo-76 electric applications.<sup>13,15,35-38</sup> Most studies have focused on 77 the optimization of the properties of CuFeS<sub>2</sub> by a proper 78 doping, and only mid-temperature properties (above 300 K) 79 for the materials have been investigated. Similarly, we 80 published a study of the partial replacement of Cu atoms by 81 Pd in the  $Cu_{1-x}Pd_xFeS_2$  system in the mid-temperature 82 region.<sup>39</sup> In the present paper, we employ a wide set of low-83 temperature measurements, intending to obtain a coherent 84 picture of all the material properties. Thus, based on low-85 temperature transport and magnetic measurements for a series se of  $Cu_{1-x}Pd_xFeS_2$  samples, we attempt to draw a picture that 87 can be generally applied for the hosting compound CuFeS<sub>2</sub>. To 88 make the discussion more conclusive, we include some other 89 nonstoichiometric compositions with the aim to manipulate 90 the concentration of native defects, which play, in our view, a 91 crucial role in CuFeS2. Thus, the present paper differs 92 substantially from previous papers as it recognizes point 93 defects as an important ingredient of the nature of CuFeS<sub>2</sub>.<sup>34</sup> We consider two profoundly different groups of native 94 95 (intrinsic) defects inherent to the CuFeS<sub>2</sub> structure. The first 96 group consists of intrinsic point defects (IPDs) such as 97 antisites and vacancies that are invariable as for time and place

<sup>98</sup> in a sample under exploration. The second group appears as a <sup>99</sup> result of anion-cation charge transfer (CT) and is called <sup>100</sup> "seeded CT defects". Both groups can be understood as defect <sup>101</sup> levels. The latter, however, is considered to participate in <sup>102</sup> extended states that are seeded by IPDs. We argue that this <sup>103</sup> accounts for the surprisingly high mobility of free carriers and <sup>104</sup> the small magnetic moment observed on Cu.<sup>22,29</sup>

First, we argue that, for the case of perfectly crystalline 105 106 stoichiometric CuFeS<sub>2</sub>, any "disorder" stems only from charge 107 fluctuation on the Fe site due to charge transfer from sulfur to 108 iron.<sup>19,23</sup> The CT fluctuations can facilitate hopping of 109 electrons from site to site at low temperatures. We start with 110 the conclusions by Sato et al.<sup>23</sup> who argue that the CT energy 111  $\Delta$  is close to zero and perhaps even negative in contrast to the <sup>112</sup> d-d spin fluctuation energy U ( $\approx$ 4 eV). This results in a <sup>113</sup> ground state composed of Fe<sup>+1</sup>, Fe<sup>+2</sup>, and Fe<sup>+3</sup> states; generally, 114  $Fe^{+3-x}$  states. Despite the CT fluctuations from sulfur to iron 115 sites, the structure maintains the AFM order. In fact, CT 116 boosts the AFM order. We suggest, however, that Fe ions can 117 also be coupled ferromagnetically in the presence of IPDs, 118 which serve as FM centers, i.e.,  $-Fe^{+3}-S^{-2}-Fe^{+3}-S^{-2}-Fe^{+3}-$ 119 AFM superexchange bridge is replaced by FM superexchange 120 bridge, e.g.,  $-Fe^{+3-x}-S^{-1}-Fe^{+3-x}-S^{-2}-Fe^{+3-x}-$ . Thus, the CT 121 is the driving force for the robust AFM order present in defect-122 free CuFeS<sub>2</sub> but induces a weak FM coupling when seeded by 123 IPDs. Although the Fe ions in antiferromagnetic CuFeS<sub>2</sub> are 124 often analyzed as an "impurity" in an anion continuum or 125 within a cluster approach, <sup>18,23</sup> the Fe and Cu atoms naturally 126 form a band with Bloch-like transport and a rather high 127 mobility in the case of the FM order.

Second, we argue that, for the case of perfectly crystalline to stoichiometric CuFeS<sub>2</sub>, the Cu atoms carry no magnetic moment and are excluded from free-carrier transport. Namely,

Cu-based bands are far from the Fermi level and adopt a 131 formally 3d<sup>10</sup> configuration.<sup>33</sup> However, IPDs may induce a net 132 magnetic moment on the Cu site, resulting in a  $3d^{10-x}$  133 configuration, which facilitates band transport within the Cu 134 d bands. In other words, due to defect-induced FM-like 135 delocalization, electrons can move within such a band with 136 much higher mobility than they would do within a strictly 137 localized Fe-based AFM structure. Additionally, this explains 138 the magnetic moment observed on Cu sites using neutron 139 diffraction.<sup>22,40</sup> We note that the sulfur-iron CT fluctuation 140 may also induce a small magnetic moment on Cu at higher 141 temperatures.<sup>33</sup> We have found extrinsic doping to be mostly 142 ineffective irrespective of the sublattice being substituted (e.g., 143 Co, Cr, Mn, P, and Cl). Thus, we assume that delocalized 144 electrons stem mainly from IPDs, even in extrinsically doped 145 samples (except for low concentrations of Pd). The 146 concentration of electrons can, however, be increased by 147 doping through a shift in stoichiometry induced by dopants, as 148 in the present case for Pd. The most prominent intrinsic defect 149 is antisite (AS) defect  $Fe_{Cu}$ , which is accessible in 150 comparatively high concentrations via a shift in the Cu/Fe 151 stoichiometry by Zn or Pd doping.<sup>37,39</sup> Furthermore, we 152 assume a rather low concentration of sulfur vacancies V<sub>S</sub>. As we 153 show below, both  $Fe_{Cu}$  and  $V_S$ , result, in fact, in Fe<sup>+2</sup> sites with 154 both donor (acceptor) and FM seeding ability. Although the 155 structure of CuFeS<sub>2</sub> remains AFM as a whole, the defects can 156 induce an FM nature locally in terms of energy and wave 157 vector space.<sup>26</sup> The results from DFT calculations are found to 158 be coherent with the conclusions drawn from the transport and 159 magnetic measurements. Although every single method 160 provides just a part of the picture, one obtains a rather 161 complete picture when taken as a whole. 162

#### 2. EXPERIMENTAL SECTION

A series of polycrystalline samples with the nominal 163 composition  $Cu_{1-x}Pd_xFeS_2$  (x = 0, 0.005, 0.01, 0.02, 0.1) 164 was synthesized from a mixture of pure elements obtained 165 from Sigma-Aldrich including Cu (4N shots), Pd (4N 166 powder), Fe (4N granular), and S (5N powder). Moreover, 167 samples with the composition  $Cu_{1.02}Fe_{0.98}S_2$  and  $Cu_{1-x}Fe_xS_2$  (x 168 = 0.01, 0.02) were prepared for comparison. All details on the 169 sample synthesis were given in our previous work on the 170  $Cu_{1-x}Pd_xFeS_2$  system<sup>39</sup> where also structural and composi- 171 tional analysis can be found in detail.

Electrical resistivity, Seebeck coefficient, and thermal 173 conductivity of the samples between 2 and 310 K were 174 measured simultaneously employing the four-probe method. 175 Thin silver wire leads were affixed to the bar-shaped samples of 176 typical dimensions  $1 \times 2 \times 12$  mm<sup>3</sup> with nickel paste. The 177 Cu<sub>1-x</sub>Pd<sub>x</sub>FeS<sub>2</sub> samples were measured using the thermal 178 transport option (TTO) of the Quantum Design PPMS 179 instrument. Due to its high resistivity, the Cu<sub>1.02</sub>Fe<sub>0.98</sub>S<sub>2</sub> sample 180 was measured using a homemade setup and the data points 181 above 10<sup>4</sup>  $\Omega$ -m (several M $\Omega$ ) should be regarded as indicative 182 only. Hall effect was measured using the electrical transport 183 option (ETO) of the PPMS instrument between -2 and 2 T 184 on bar-shaped samples with four silver leads welded to the 185 sample. 186

The magnetic properties were investigated by the SQUID <sup>187</sup> magnetometer Quantum Design MPMS-XL7 with the <sup>188</sup> reciprocating sample option. Measurements were performed <sup>189</sup> on small samples (sized about  $1 \times 1 \times 1$  mm<sup>3</sup> and weighing <sup>190</sup> about 10 mg) placed in between two concentric transparent <sup>191</sup>

192 plastic straws without the use of any glue. The samples were 193 reciprocated between the pick-up coils at 1 Hz with an 194 amplitude of 4 cm. Isothermal magnetization curves M(H)195 were obtained between by stepping the field in driven mode 196 between 7, -7, and 7 T. When changing the sample 197 temperature, the field was zero. For thermoremanence 198 measurements, the samples were magnetized to 7 T at 3 K, 199 the field was then reduced to 0 and the magnet quenched. 200 Subsequently, the evolution of the remanent magnetization 201 was measured while sweeping the temperature from 3 to 390 K 202 at a rate of 2 K/min below 9 K and 5 K/min above 9 K.

203 The transmission <sup>57</sup>Fe Mössbauer spectroscopy of CuFeS<sub>2</sub> 204 and Cu<sub>0.9</sub>Pd<sub>0.1</sub>FeS<sub>2</sub> powder samples was employed to study the 205 local magnetic properties of the samples (see Supporting 206 Information, section C). The spectra were acquired at 4.2 K 207 and room temperature by using the <sup>57</sup>Co/Rh source and 208 evaluated in the Confit<sup>41</sup> and Recoil<sup>42</sup> programs, and the 209 calibration of velocities and isomer shifts was performed with 210 respect to an  $\alpha$ -Fe foil at room temperature. The in-field 211 spectra at 6 T were measured at 4.2 K in a liquid-helium bath 212 cryostat by Janis Research with the orientation of the applied 213 field perpendicular to the direction of  $\gamma$ -rays.

The calculations were made with the WIEN2k program.<sup>43</sup> 214 215 This program is based on the density functional theory (DFT) 216 and uses the full-potential linearized augmented plane-wave 217 (FP LAPW) method with the dual basis set. The space of the 218 unit cell is divided into atomic spheres and the interstitial 219 region. The calculations were made either in the basic unit cell 220 with formula units Z = 4 and for the defect simulations in the 221 eight times enlarged supercell with Z = 32 defined by  $aS = 2a_0$ 222 bS = 2b, and cS = 2c. The number of k-points in the irreducible 223 part of the Brillouin zone was 108 for the basic unit cell (Z =224 4) and 93 for the supercell (Z = 32). All calculations were spin-225 polarized. For the exchange correlation potential, we adopted 226 the generalized gradient approximation (GGA) form.<sup>44</sup> To 227 improve the description of 3d electrons, we used the GGA+U 228 method. In this method, an orbitally dependent potential is 229 introduced for the chosen set of electron states, i.e., for the 3d 230 states. This additional potential has an atomic Hartree-Fock 231 form but with screened Coulomb and exchange interaction 232 parameters. The fully localized limit version of the GGA+U 233 method was employed. The parameters U = 2 eV and I = 1 eV 234 were used. Several parameters of U and J were tested in the 235 GGA+U calculations resulting in different sizes of band gap. 236 The presented results were obtained with parameters U = 2 eV237 and J = 1 eV, which were selected according to the best 238 agreement of the calculated and the experimentally determined 239 band gap.<sup>3,31</sup> The calculations of the electrical transport 240 properties were done within Boltzmann transport theory using 241 the BoltzTrap package<sup>45</sup> under the constant relaxation time 242 approximation for the charge carriers.

#### 3. RESULTS AND DISCUSSION

**3.1. Charge Transport Properties.** The low-temperature 244 resistivity showing typical semiconducting behavior is depicted 245 in Figure 1. It can be concluded that Pd substitution for Cu, 246 i.e., point defect  $Pd_{Cu}$  leads to a substantial decrease in the 247 resistivity, which generally indicates the donor effect of the Pd. 248 The equation  $xPd^{+2}S + Cu^{+1}FeS_2 \rightarrow Cu_1^{+1}Pd_x^{+2}FeS_{2+x}$  reflects 249 the formation of  $Pd_{Cu}^{+2} \rightarrow Pd_{Cu}^{+3} + e^-$ .  $Pd_{Cu}^{+3}$  is available in 250 through excitation  $Pd_{Cu}^{+2} \rightarrow Pd_{Cu}^{+3} + e^-$ .  $Pd_{Cu}^{+3}$  is available in 251 tetrahedral coordination due to the  $(e_g)^4(t_{2g})^3$  configuration. 252 However, the doping effect is largely connected with the shift



**Figure 1.** Temperature-dependent electrical resistivity of  $Cu_{1-x}Pd_xFeS_2$  ( $0 \ge x \ge 0.1$ ) and  $Cu_{1.02}Fe_{0.98}S_2$ . Green shaded symbols above  $10^4 \Omega \cdot m \ (\approx 10 \ M\Omega)$  are at the facility resolution limit and should be considered as a tendency.

in the Cu/Fe stoichiometry. Thus, for x > 0.01, the equation 253  $(\operatorname{Cu}_{1-x}^{+1}\operatorname{Pd}_{x}^{+2})\operatorname{FeS}_{2} \rightarrow (\operatorname{Cu}_{1-x}^{+1}\operatorname{Pd}_{x-y}^{+2}\operatorname{Fe}_{y}^{+2})\operatorname{FeS}_{2} + y\operatorname{PdS}$  reflects 254 the donor effect leading to the degenerate state for x = 0.1.<sup>39</sup> 255 Namely, the excitation  $Fe_{Cu}^{+2} \rightarrow Fe_{Cu}^{+3} + e^{-}$  represents the doping 256 process. The excess of Pd is segregated during the growth in 257 the form of PdS.<sup>39</sup> We performed a detailed exploration of the 258 resistivity data using  $\ln \rho = f(T^{-1/p})$  fitting with the aim of 259 revealing the nature of charge transport in detail (see 260 Supporting Information, section A). The examined temper- 261 ature range is split into three regions with different y values, 262 indicating three different charge transport mechanisms in 263 accordance with the analysis given in refs 34, 46. Generally, the 264 high-temperature region can be fitted using an Arrhenius plot 265  $\ln \rho = f(T^{-1})$  with a rather low activation energy E = 25 meV 266 connected with band transport. The mid-region is dominated 267 by 3D Mott variable-range hopping (VRH),<sup>47</sup> while Efros- 268 Shklovskii VRH dominates in the low-temperature region, 269 especially for samples with a very low concentration of free 270 carriers. A very low free-carrier concentration in Cu<sub>1.02</sub>Fe<sub>0.98</sub>S<sub>2</sub> 271 guarantees an Efros–Shklovskii VRH mechanism up to ~100 272 K, while no Efros-Shklovskii VRH mechanism is observed in 273 heavily doped samples due to the rather high concentration of 274 electrons. Figure 2 depicts the Hall coefficient  $R_{\rm H}$  as a function 275 f2



**Figure 2.** Hall coefficient  $R_{\rm H}$  and calculated Hall free-carrier concentration  $n \ (-1/(R_{\rm H}\cdot e))$  as a function of temperature for  ${\rm Cu}_{1-x}{\rm Pd}_x{\rm FeS}_2 \ (0 \ge x \ge 0.1)$  and  ${\rm Cu}_{1,02}{\rm Fe}_{0.98}{\rm S}_2$  samples.

276 of temperature and corresponding Hall free-carrier concen-277 tration  $n_{\rm H}$  obtained from the relation  $n_{\rm H} = -1/(R_{\rm H} \cdot e)$ , where e 278 is the electron charge. For non-degenerate samples, we observe 279 a common feature: a very small concentration of electrons is 280 generated below 10 K and saturation between 10 and 40 K, 281 thus producing a shallow minimum. However, we note that 282 such a minimum in  $R_{\rm H}$  is attributable to thermal hopping as 283 well (see, e.g., Avdonin<sup>48</sup>). Then, due to another excitation, the 284 free-carrier concentration steeply grows from 40 to 50 K up to 285 300 K. This excitation can be attributed to AS defects  $Fe_{Cu}$ 286 for  $Cu_{1-x}Pd_xFeS_2$  and sulfur vacancies for  $Cu_{1.02}Fe_{0.98}S_2$ . This 287 excitation disappears when approaching the degenerate regime,  $_{288}$  and the highly degenerated  $\bar{Cu}_{0.9}Pd_{0.1}FeS_2$  sample shows a high 289 and almost constant free-carrier concentration  $(\sim 2.10^{20} \text{ cm}^{-3})$ in the whole measured temperature range. This indicates a 290 merging of the defect level (band) into the conduction band 291 minimum with increasing concentration of AS defects, which is 292 in accordance with DFT calculations, as described below. In 293 contrast to the stoichiometric sample, the free-carrier 294 <sup>295</sup> concentration in the  $Cu_{1.02}Fe_{0.98}S_2$  sample remains to be very <sup>296</sup> low at 300 K (4.5 × 10<sup>18</sup> cm<sup>-3</sup>). We premise that magnetic 297 measurements insinuate a small concentration of sulfur 298 vacancies and depletion of AS defects Fe<sub>Cu</sub>, which is consistent 299 with the overstoichiometry of copper. Some remarks should be 300 pointed out here. First, the resistivity of the  $Cu_{1,02}Fe_{0.98}S_2$ 301 sample is so high that, at low temperatures, the accuracy of the 302 data is at the limit for the used equipment and may somewhat 303 deviate from true values. More importantly, the hopping 304 mechanism may become dominant for non-degenerate samples 305 at very low temperatures (see Supporting Information, section 306 A). Thus, utilization of a simple formula for the Hall concentration is inaccurate under such circumstances.<sup>48</sup> 307 308 Therefore, we consider that such analysis of the Hall data is 309 reliable for all degenerate samples, but for non-degenerate 310 samples, it is reliable only above  $\approx$ 80 K. Similarly, this applies 311 to the calculated Hall mobility  $\mu_{\rm H}$  (Figure 3), and we consider





**Figure 3.** Hall mobility  $\mu_{\rm H}$  ( $R_{\rm H}/\rho$ ) as a function of temperature for  ${\rm Cu}_{1-x}{\rm Pd}_x{\rm FeS}_2$  ( $0 \ge x \ge 0.1$ ) and  ${\rm Cu}_{1.02}{\rm Fe}_{0.98}{\rm S}_2$  samples.

312 the low-temperature data for the non-degenerate samples on a 313 relative scale only. Strikingly, the magnitude of the mobility 314 (and resistivity) above 80 K contradicts the antiferromagnetic 315 (AFM) order of the hosting structure for stoichiometric 316 CuFeS<sub>2</sub> and Pd-doped samples. Namely, a strict AFM order 317 dictates localization of d electrons. However, we observe electric transport within a dispersive band. We address this 318 issue in the following section. 319

**3.2. Intrinsic Defects and Band-Structure Calcula-** <sup>320</sup> **tions.** The band structure proposed from optical measure- <sup>321</sup> ments for CuFeS<sub>2</sub> single crystals hints at the existence of "an <sup>322</sup> upper valence band" or "an additional conduction band", i.e., a <sup>323</sup> band lying inside the broader energy gap of  $\approx 0.5$  eV. This <sup>324</sup> band is mostly formed by the hybridized 3d orbitals of Fe and <sup>325</sup> 3p orbitals of S, and its edge corresponds to the initial point of <sup>326</sup> the band-to-band transition. <sup>7,26,33</sup> The present results obtained <sup>327</sup> from DFT calculations for the defect-free structure are in <sup>328</sup> accordance with previously published data. <sup>33,49</sup> <sup>329</sup>

In our previous paper,<sup>39'</sup> we assumed a specific shape for the 330 bottom of the conduction band to account for evidence of 331 high-mobility Fe d orbital-derived electrons. However, based 332 on the present experiments and DFT calculations, we revise 333 the picture drawn in our previous paper. In our view, the 334 appearance of both "light and heavy" electrons is connected 335 with a non-negligible concentration of IPDs. The experimental 336 and theoretical data available point toward the presence of two 337 types of intrinsic defects, Fe<sub>Cu</sub> and V<sub>S</sub>. This explains the 338 "specific shape of the conduction band edge" mentioned in our 339 previous paper. Namely, the occurrence of  $V_S$  and  $Fe_{Cu}$  (or 340 their combination) results in distinct FM states close to the 341 Fermi level (Figure 4AA,B). This conclusion is in accordance 342 f4 with free-carrier concentration-dependent FM, as discussed for 343 the magnetic properties (Section 3.3). Thus, we assume two 344 types of free carriers and two types of corresponding magnetic 345 order exist in CuFeS<sub>2</sub>, with both connected to IPDs. 346

The starting point of our consideration is the neutrality of 347 CuFeS<sub>2</sub> as a whole. An Fe atom placed on the Cu site can 348 adopt, e.g.,  $Fe_{Cu'}^{+3}$ ,  $Fe_{Cu'}^{+2}$  or  $Fe_{Cu}^{+1}$  states. This, in turn, induces 349  $Fe_{Fe}^{+1}$ ,  $Fe_{Fe}^{+2}$ , or  $Fe_{Fe}^{+3}$  states, respectively, for neighboring Fe sites 350 within Fe<sub>2</sub>Cu<sub>2</sub>S tetrahedra. This may be reflected in FM 351 coupling within  $-Fe^{+3-z}-S^{-2}-Fe^{+3-z}-S^{-2}-Fe^{+3-z}$  bridges, 352 i.e., the formation of seeded CT defects (Figure 5(left)). The 353 f5 AS defect can be viewed as a hard excitation. Similarly, Fe<sub>Cu</sub> 354 may dictate the CT nature within  $-Cu^{+1-z}-S^{-2}-Cu^{+1-z}-355$  $S^{-2}-Cu^{+1-z}$  bridges that induces a weak FM (Figure 356 5(right)). The sulfur vacancy V<sub>S</sub> plays a similar role. Accepting 357 the ionic picture of CuFeS<sub>2</sub> in the form of  $Cu^{+1}Fe^{+3}S_2^{-2}$ , 5,6,17,23 358 we have to recognize that  $V_s$ , in fact, represents two Fe<sup>+2</sup> point 359 defects. Namely, the corresponding Fe d electrons remain 360 localized at Fe atoms instead of being transferred to sulfur 361 within the ionic-covalent bond. Thus, a missing sulfur atom 362 produces a -Fe<sup>+2</sup>-V<sub>S</sub>-Fe<sup>+2</sup>- defect. Strictly speaking, from a 363 purely ionic view, each Fe transfers 0.75 electrons to S in 364 Fe<sub>2</sub>Cu<sub>2</sub>S tetrahedra. Thus, the defect should read -Fe<sup>+2.25</sup>- 365  $V_{s}$ -Fe<sup>+2.25</sup>-. We adhere to the former simplified notation 366 since it makes no difference in our qualitative discussion. The 367 formation of such a defect, in turn, implies the appearance of, 368 e.g., -Fe<sup>+2</sup>-S-Fe<sup>+3</sup>- chains in the neighborhood, which 369 induces FM coupling instead of the common AFM coupling in 370 the hosting structure<sup>50,51</sup> (Figure 6). Moreover, the sulfur 371 f6 atom is coordinated by two Fe atoms and two Cu atoms 372 (Fe<sub>2</sub>Cu<sub>2</sub>S tetrahedra). The Cu atoms also keep their electrons 373 when neighboring with  $V_s$ , which formally reads as  $-Cu^{+0.75}$ - 374  $V_S-Cu^{+0.75}$ -. Thus, similar to  $Fe_{Cu}$ ,  $V_S$  may induce a weak FM 375 coupling within  $-Cu^{+1-z}-S^{-2}-Cu^{+1-z}-S^{-2}-Cu^{+1-z}$  seeded 376 CT defects. In this case, the formal charge of copper is lower 377 than +1, resulting, formally, in a  $3d^{10-x}$  configuration for a 378 single ion. Note that, in defect-free CuFeS<sub>2</sub>, indirect 379 participation of Cu atoms in CT is also likely to induce a 380

D



Figure 4. (A) Comparison of the calculated density of states (DOS) projected onto atomic spheres for a formally defect-free structure  $(Cu_{32}Fe_{32}S_{64})$  and structures with simulated defects: 6% of Cu sites occupied by Fe  $(Cu_{30}Fe_2Fe_{32}S_{64})$ , 3% by S vacancies  $(Cu_{32}Fe_{32}S_{62})$ , and both defects together  $(Cu_{30}Fe_2Fe_{32}S_{62})$ . (B) The same in detail around the Fermi level.



**Figure 5.** Fe<sub>Cu</sub> AS defect. This figure depicts two of many plausible (resonant) states that induce a weak FM coupling due to AS defects  $Fe_{Cu}^{+2}$ . The blue arrows represent the CT seeded by the AS defect. Left, in the Fe sublattice; right, in the Cu sublattice. *z* represents the average amplitude of the induced CT. Note that Cu<sup>+1 - z</sup> corresponds to the  $3d^{9+z}4s^1$  configuration. Point defects induce mixing of 4s orbitals into the conduction band minimum states. The gray double arrows represent plausible weak sulfur-mediated FM couplings. Red, green, and yellow circles represent iron, copper, and sulfur, respectively. The fading color indicates a change in the oxidation state corresponding to *z*.

<sup>381</sup> weak FM order at elevated temperatures.<sup>33,40</sup> Note that <sup>382</sup> ordinary CT strengthens and retains the AFM exchange within <sup>383</sup> Fe<sup>+3</sup>–S–Fe<sup>+3</sup>, although it decreases the magnetic moment of <sup>384</sup> the Fe ions.<sup>4,33,52</sup> In the light of the magnetic measurements <sup>385</sup> discussed below, we anticipate that lone sulfur vacancies occur <sup>386</sup> with a rather low concentration. From this viewpoint, their <sup>387</sup> presence is less obvious in transport and magnetic properties. <sup>388</sup> However, DFT calculations indicated that their combination <sup>390</sup> structure and thus the chalcopyrite properties. Specifically, a <sup>391</sup> lone V<sub>S</sub> is less efficient in introducing Cu-based states into <sup>392</sup> relevant parts of the band structure. In order to provide a <sup>393</sup> better insight, we present a simple 3D representation of FM <sup>394</sup> induced by Fe<sub>Cu</sub> point defect in Figure 7. A picture of the FM <sup>395</sup> order induced in Cu sublattice is analogical.

In our view, the defect-induced weak FM coupling facilitates r free-carrier transport in CuFeS<sub>2</sub> and constitutes a mechanism

f7



Figure 6. Sulfur vacancy. A sulfur vacancy V<sub>s</sub> (blue open circle) can be interpreted as two electrons localized on neighboring Fe/Cu atoms. The defects, thus, formally read as  $Fe^{+2}-V_S-Fe^{+2}/Cu^0-V_S-$ Cu<sup>0</sup>, which dictates (seeds) the feasible CT along the next neighboring S-Fe/S-Cu bonds (blue arrows) in the horizontal direction (Fe<sup>+3-z</sup>/Cu<sup>+1-z</sup> lines). This, in turn, increases the probability of formation of FM chains within CT in the horizontal direction, seeded CTDs. x represents the average amplitude of the induced CT. Note the ordinary CT averages, producing the AFM order otherwise. Sulfur charge is omitted for simplicity. The figure depicts some plausible (resonant) states. Note that each S atom bonds to just two Fe and two Cu atoms, while each Fe (Cu) atom coordinates to four sulfur atoms. The picture is a schematic 2D representation. Red, green, and yellow circles represent iron, copper, and sulfur, respectively. The fading color indicates a decrease in the oxidation state corresponding to z.

for the surprisingly high mobility and tiny FM signal observed 398 in AFM CuFeS<sub>2</sub> (please see also the discussion of magnetic 399 properties, Seebeck coefficient, and thermal conductivity, 400 which corroborates this conclusion). We understand the 401 seeding as a process of formation of extra band features 402 induced by IPDs. Note that all IPDs or their combination form 403 spin-polarized extra states within the gap (Figure 4A,B). IPDs 404 narrow the band gap due to the formation of extra states in the 405 vicinity of the conduction band minimum or valence band 406 maximum. More importantly, IPDs introduce Cu 3d orbitals 407 into the vicinity of the  $E_{\rm F}$ .



Figure 7. 3D representation of the FM order induced in the Fe sublattice by the AS defect  $Fe_{Cu}$  (Fe<sup>+2</sup>). The FM stems from Fe<sup>+3</sup>– $S^{-2}$ –Fe<sup>+2</sup>– $S^{-2}$ –Fe<sup>+3</sup> (Fe<sup>+3-z</sup>– $S^{-2}$ –Fe<sup>+3-z</sup>– $S^{-2}$ –Fe<sup>+3-z</sup>) bridges.

409 Thus, with the assistance of DFT calculations, we consider 410 that a combination of two types of free carriers participates in 411 the transport. The first type is connected with FM excitation 412 within  $-\text{Fe}^{+3}-\text{S}^{-2}-\text{Fe}^{+2}-\text{S}^{-2}-\text{Fe}^{+3}-$  bridges; the second type 413 is connected with FM excitations within  $-\text{Cu}^{+1}-\text{S}^{-2}-\text{Cu}^{+1}-$ 414  $\text{S}^{-2}-\text{Cu}^{+1}-$  bridges. The former provides a rather lower 415 mobility of  $\mu \approx 10 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  due to it being a part of the 416 AFM background of Fe. The latter provides a higher mobility 417 of  $\mu \approx 100 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  due to it being formed within the 418 formally diamagnetic (non-polarized) background of Cu. The 419 defect-induced states are detailed in Figure 4A,B. To better 420 visualize the effect of IPDs in the DFT calculations, we assume 421 a much higher concentration of defects (2/32 for FeCu and 2/ 422 64 for VS) than that in the real material.

<sup>423</sup> In reality, the presence of defect-induced orbitals within the <sup>424</sup> band gap can be rather low (especially for Cu orbitals) and <sup>425</sup> may span a narrower energy range. Thus, their participation in <sup>426</sup> transport can be strongly dependent on the Fermi level  $E_{\rm F}$ , <sup>427</sup> which may explain the observed free-carrier concentration-<sup>428</sup> dependent mobility (Figure 3). Although DFT calculations are <sup>429</sup> always inaccurate, we argue that they still do reflect the <sup>430</sup> tendency of the system correctly. We note that increasing the number of atoms in the cell 2-fold keeps the DFT outputs 431 comparable. Moreover, a BoltzTrap-derived calculation for 432 both defects shows a negative Seebeck coefficient in contrast to 433 defect free CuFeS<sub>2</sub>, which is in accordance with the experiment 434 (Supporting Information, section B). 435

The Fe<sub>Cu</sub> veraciously reflects the n-type conductivity in 436 terms of Hall and Seebeck coefficient measurements (Figures 2 437 and 12), which is difficult to obtain for stoichiometric  $CuFeS_2$  438 (Figure 4A,B and Figure 4S). The Fermi level is located at the 439 bottom of the conduction band for the 2/32 concentration. In 440 fact, Fe<sub>Cu</sub>-derived states merge with the conduction band 441 minimum. We assume that, for lower Fe<sub>Cu</sub> concentrations, the 442 states remain separated from the minimum, forming a donor  $^{443}$  level as indicated by experiments.  $^{34,36,39}$  In contrast,  $V_S$  merges  $^{444}$ the Fermi level into the valence band maximum. This suggests 445 acceptor-like behavior in the low-temperature region (Figure 446 4S). Notably, both the defects and their combination break the 447 spin-up/spin-down symmetry of the DOS for the strictly AFM 448 order of the hosting structure, implying a local FM order. We 449 note that, in contrast to  $Fe_{Cw}$  the concentration of V<sub>S</sub> is 450 generally insensitive to an intentional sulfur stoichiometry 451 variation according to preliminary experiments. We estimate 452 the concentration of  $Fe_{Cu}^{+2}$  species involved in FM coupling at 453 300 K (3 K) as  $9 \times 10^{18}$  (2.3 × 10<sup>19</sup>) cm<sup>-3</sup>, while most of the 454 AS defects ( $\approx 10^{20}$  cm<sup>-3</sup>) form Fe<sub>Cu</sub><sup>+3</sup> resulting in doping. The 455 concentration of V<sub>S</sub> is far lower. For details, please see 456 Supporting Information, section D. 457

**3.3. Magnetic Properties.** The hysteresis loops evidence a  $_{458}$  distinct ferromagnetic contribution (Figure 8A,B). We note  $_{459}$  f8 that Mössbauer spectroscopy corroborates the picture of an  $_{460}$  AFM matrix with a weak FM contribution (see Supporting  $_{461}$  Information, section C). The complex and inhomogeneous  $_{462}$  magnetic state is confirmed from the exchange bias field.  $_{463}$  Exchange bias is a measure of the interaction between the main  $_{464}$  AFM phase and minority FM phase. More importantly, the  $_{465}$  two phases must be magnetically coupled, which corroborates  $_{466}$  the idea of IPDs induced on the background of an AFM  $_{467}$  matrix. The field magnitude is proportional to the contact area  $_{468}$  between the AFM and FM phases. Thus, we observe a coupled  $_{469}$  mixture of AFM matrix containing FM defects/inclusions. The  $_{470}$  exchange bias is well observable even for Cu<sub>1.02</sub>Fe<sub>0.98</sub>S<sub>2</sub> despite 471 its weak hysteresis. (Figure 8A,B); the overstoichiometry of 472



**Figure 8.** (A, B) Magnetization as a function of magnetic field H for the studied samples at 3 K in the range of (A)  $-70 \le H \le 70$  kOe and its magnification (B)  $-3.5 \le H \le 3.5$  kOe revealing the observed exchange bias field.





473 copper lowers the concentration of  $Fe_{Cu}$  defects resulting in a 474 negligible FM signal and free-carrier concentration (Figure 2). 475 This composition shows the lowest concentration of FM 476 defects, as discussed below. The doped samples show 477 increasing values of coercivity and remanence with increasing 478 Pd concentration. However, both the coercivity and 479 remanence is smaller than that of stoichiometric CuFeS<sub>2</sub> for 480 x < 0.01, which is consistent with the formation of Pd<sub>Cu</sub> 481 defects. Similar to the Cu overstoichiometry, a small 482 concentration of Pd led to a decrease in the concentration of 483 Fe<sub>Cu</sub> and V<sub>S</sub> in stoichiometric CuFeS<sub>2</sub> (please compare with 484 the discussion of thermoremanence and thermal conductivity). 485 Accordingly, a low concentration of Pd is connected with a low 486 FM signal and vanishing exchange bias. This clearly indicates 487 that the point defects are crucial elements for pinning of the 488 FM phase to the AFM matrix. The observed asymmetry in the 489 remanence (Figure 8B) reveals that not all pinned FM spins 490 are rotated by switching the magnetic field. However, note the 491 exceptional behavior of CuFeS<sub>2</sub>. This sample shows the highest 492 exchange bias but a vanishing remanence asymmetry, clearly 493 indicating a different nature for the FM. Note that CuFeS<sub>2</sub> and 494 Cu<sub>0.9</sub>Pd<sub>0.1</sub>FeS<sub>2</sub> show a comparable coercivity but different 495 remanence.

To shed more light on this issue, we measured the magnetic 496 497 thermoremanence (Figure 9A,B). First, upon heating, the 498 doped samples, particularly, and undoped samples, partially, show a well-pronounced decrease in remnant magnetization at 499 500 ≈120 K. We attribute this behavior to CT defects seeded by 501 Fe<sub>Cu</sub>, which are coupled to the AFM host structure below the 502 critical temperature of  $T_{\rm C1} \approx 120$  K. Another critical 503 temperature appears at  $T_{C2} \approx 55$  K for  $Cu_{1.02}Fe_{0.98}S_2$ . We 504 tentatively attribute this signal to V<sub>S</sub>. If true, the Pd 505 substitution for Cu or the shift in Fe/Cu stoichiometry so reduces the formation of  $V_{S_2}$  as follows from Figures 8 and 9. Clearly, the overstoichiometry of Cu tends to purify the 507 508 CuFeS<sub>2</sub> as for magnetic IPDs. This is consistent with the 509 analysis of thermal conductivity in Section 3.4. However, we s10 observe a  $T_{C3} \approx 30$  K for undoped sample CuFeS<sub>2</sub> that is 511 difficult to address. After all considerations, we tentatively <sup>512</sup> attribute this FM signal to clustering of  $Fe_{Cu}$  and  $V_S$ , similar to <sup>513</sup> that observed in CuInSe<sub>2</sub>.<sup>53</sup> Admittedly, this issue is still open. 514 The fast decrease in the magnetization upon heating due to the 515 paramagnetic background at the lowest temperature is highly 516 pronounced for Cu<sub>0.9</sub>Pd<sub>0.1</sub>FeS<sub>2</sub> due to a higher free-carrier 517 concentration and PdS. The seeded CT defects can be viewed

as a transient state between the  $CuFeS_2$  and some derived 518 structures, e.g., FM cubanite  $CuFe_2S_3$ , which is a well-known 519 process for, e.g.,  $CuInSe_2$ .<sup>53</sup> In contrast to polycrystals, we do 520 observe intergrown cubanite in single-crystalline  $CuFeS_2$ . 521

**3.4. Thermal Conductivity.** Figure 10 depicts the low- 522 f10 temperature thermal conductivity  $\kappa$  from 3 to 300 K. The 523



**Figure 10.** Thermal conductivity as a function of temperature (2–310 K) of  $Cu_{1-x}Pd_xFeS_2$  ( $0 \ge x \ge 0.1$ ) and  $Cu_{1.02}Fe_{0.98}S_2$  samples.

electronic part of the total thermal conductivity estimated 524 using the Wiedemann-Franz law is negligible (less than 1%) 525 for all samples near room temperature except for the 526 degenerate  $Cu_{0.9}Pd_{0.1}FeS_2$  sample (approximately 2%). We 527 notice that the highest peak values for  $\kappa$  are found for the 528  $Cu_{1.02}Fe_{0.98}S_2$  sample (86 W m<sup>-1</sup> K<sup>-1</sup> at 23 K), which is 529 consistent with the very low concentration of Vs. Close 530 inspection of the  $\kappa = f(T)$  curves reveals the presence of 531 another contribution to the thermal conductivity besides the 532 phononic (and electronic) contribution. This contribution is 533 most pronounced for the Cu<sub>0.99</sub>Pd<sub>0.01</sub>FeS<sub>2</sub> sample (dark blue 534 circles in Figure 10), appearing as a shoulder on the  $\kappa = f(T)$  535 curve at approximately 30 K. We observe a related effect in the 536 Seebeck coefficient (Section 3.5). We attribute the extra 537 thermal conductivity to magnon-assisted heat transport.<sup>14,54</sup> 538 To estimate the magnitude of this contribution, we assume 539 that, up to approximately 30 K, a phononic contribution 540 dominates, which enables us to fit the  $\kappa = f(T)$  dependence of 541

542 the  $Cu_{0.99}Pd_{0.01}FeS_2$  sample up to this temperature using the 543 Debye formula for the phonon thermal conductivity:

$$\kappa_{\rm ph} = \frac{k_{\rm B}}{2\pi^2 v} \left(\frac{k_{\rm B}}{\hbar}\right)^3 T^3 \int_0^{\Theta_{\rm D}/T} \tau(\omega, T) \frac{x^4 {\rm e}^x}{({\rm e}^x - 1)^2} {\rm d}x$$
(1)

0 / 77

545 where  $\tau(\omega,T)$  is the mean lifetime of a phonon,  $\omega$  is its angular 546 frequency, v is the average sound velocity,  $\Theta_{\rm D}$  is the Debye 547 temperature ( $\Theta_{\rm D} = 263 \text{ K}^{55}$ ), and  $x = \hbar \omega / k_{\rm B}T$ .  $\tau$  can be 548 approximated by

$$\tau^{-1} = \frac{\upsilon}{d} + A\omega^4 + B\omega^2 T \exp\left(-\frac{\Theta_{\rm D}}{CT}\right)$$
(2)

s50 where *d* is the smallest crystal dimension and *A*, *B*, and *C* are s51 fitting parameters independent of temperature. The three s52 terms correspond to phonon scattering at crystal boundaries s53 and point defects and phonon–phonon *U* processes, s54 respectively. The obtained fit was then extrapolated toward s55 higher temperatures, and the assumed magnetic contribution s56 was calculated by subtracting the phonon part from the s57 experimental part, i.e.,  $\kappa_{mag} = \kappa_{exp} - \kappa_{ph}$ . The estimated error s58 deviations from  $\kappa_{ph}$  are shown by the thick red line in Figure s59 11. One can see that the magnetic contribution even exceeds



Figure 11. Separation of lattice thermal conductivity (diamonds) into phonon (red line) and magnon (green line) contributions for the  $Cu_{0.99}Pd_{0.01}FeS_2$  sample.

<sup>560</sup> the phononic contribution at higher temperatures. Similar <sup>561</sup> contributions are also inherent to other samples, although they <sup>562</sup> are less pronounced in  $\kappa \approx f(T)$ . Although with an increasing <sup>563</sup> uncertainty, the same procedure indicates that magnons play a <sup>564</sup> non-negligible role in other samples. This is in accordance with <sup>565</sup> the discussion in the sections above and, most importantly, corroborates the fact that the magnon excitation spectrum has 566 a gap of ca. 1.3 THz, which limits the magnon role at low 567 temperatures.<sup>4</sup> 568

We return now to the analysis of the phonon part of the 569 thermal conductivity. As a starting point, we choose a very 570 small value of A for Cu<sub>1.02</sub>Fe<sub>0.98</sub>S<sub>2</sub>, which indicates an almost 571 defect-free structure (Table 1). The increase in the A 572 ti parameter indicates the increasing concentration of Pd<sub>Cu</sub> and 573 Fe<sub>Cu</sub> due to Pd doping. In addition, we observe a small drop in 574 A for x = 0.005, suggesting that the true substitution of Pd for 575 Cu rather hinders the formation of AS defects, which is in 576 accordance with the comparatively lower magnetization of the 577 slightly doped samples. A further increase in A corresponds to 578 the formation of AS defects due to the shift in the Cu/Fe 579 stoichiometry. The crystalline size L culminates for small  $x_{1,580}$ indicating that substitutional Pd facilitates the growth/quality 581 of microcrystals. The same applies for the overstoichiometry of 582 Cu, although it is not so pronounced. This phenomenon 583 occurs due to eutectic formation.<sup>56</sup> A high content of Pd 584 reduces L profoundly, which is connected with the extensive 585 formation of the extraneous PdS phase. The Umklapp 586 scattering parameter B is difficult to address since it is largely 587 affected by the magnetic contribution  $\kappa_{mag}$ .

**3.5. Seebeck Coefficient.** Figure 12 summarizes the 589 f12 Seebeck coefficient *S* as a function of temperature. Negative 590



**Figure 12.** Seebeck coefficient as a function of temperature (2-310 K) for  $\text{Cu}_{1-x}\text{Pd}_x\text{FeS}_2$   $(0 \ge x \ge 0.1)$  and  $\text{Cu}_{1.02}\text{Fe}_{0.98}\text{S}_2$  samples. The  $\text{Cu}_{1.02}\text{Fe}_{0.98}\text{S}_2$  sample was measured down to only 30 K due to its high resistivity.

values over the whole temperature range indicate dominant 591 electron transport. However, two of the non-degenerate 592 samples,  $CuFeS_2$  and  $Cu_{0.995}Pd_{0.005}FeS_2$ , show positive values 593 for the Seebeck coefficient at very low temperatures (not 594 shown here), which hint at p-type conductivity; unfortunately, 595 the resistivity of these samples is so high (see Figure 1) that 596

Table 1. Values of Selected Parameters Obtained by Fitting Experimental Lattice Thermal Conductivities  $\kappa_{lat}$  by Means of Debye Formula (eqs 1 and 2)<sup>*a*</sup>

sample	$A (10^{-43} s^3)$	$B (10^{-18} \text{ s} \cdot \text{K}^{-1})$	$L(\mu m)$	$ ho/ ho_{ m cryst}  imes 100~(\%)$
$Cu_{1.02}Fe_{0.98}S_2$	$0.9 \pm 0.3$	$9.5 \pm 1.5$	$9.0 \pm 0.5$	98.5
CuFeS <sub>2</sub>	$8.8 \pm 0.6$	$5.5 \pm 1.5$	$5.7 \pm 0.3$	98.5
$Cu_{0.995}Pd_{0.005}FeS_2$	$6.7 \pm 0.7$	$8.0 \pm 3.0$	$20.0 \pm 1.0$	98.0
$Cu_{0.99}Pd_{0.01}FeS_2$	$10.0 \pm 1.0$	$12.0 \pm 3.0$	$18.0 \pm 1.0$	98.0
$Cu_{0.9}Pd_{0.1}FeS_2$	$27. \pm 0.5$	$20.0 \pm 1.0$	$3.7 \pm 0.1$	~97 <sup>b</sup>

"Densities of the hot-pressed pellets used for the measurements as compared to theoretical values are listed in the last column. <sup>b</sup>Theoretical value of composite 93.5% wt % of CuFeS<sub>2</sub> and 6.5 wt % of PdS was considered for the calculation.<sup>39</sup>

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597 the data may be disputable. Similarly, the high resistivity of 598 Cu<sub>1.02</sub>Fe<sub>0.98</sub>S<sub>2</sub> prevents measurement of the Seebeck coefficient 599 below 30 K. The S values for the samples with high free-carrier 600 concentrations monotonically decrease with temperature, 601 showing a typical behavior for a degenerate semiconductor. 602 However, for non-degenerate samples, the absolute values for S 603 saturate between 200 and 300 K and then drop to zero with 604 decreasing temperature with a peak of approximately 30-50 K 605 in between. This feature has been recently explained by an 606 energy-dependent scattering time due to a hopping mecha-607 nism.<sup>34</sup> The energy-dependent scattering can account for the 608 shape of the S = f(T) curves but fails to account for the high 609 mobility. Hence, we suggest an alternative model. In fact, the 610 analysis below shows that an energy-dependent effective 611 mass<sup>34</sup> can account for the temperature dependence of the 612 Seebeck coefficient and the energy-dependent scattering time. We used the Hall free-carrier concentration  $n_{\rm H}$  to fit the 613 614 general shape of S = f(T). We excluded the negligible 615 magnitude of the phonon drag component in the studied 616 polycrystalline materials and assumed that the Seebeck 617 coefficient arises mostly due to carrier diffusion. For the 618 pristine sample, we supposed that two types of carriers 619 (electrons) participate in the transport. The first carrier 620 dominates at low temperatures (ca. up to 50 K) and its 621 concentration is constant (see Figure 2), while the other 622 carrier dominates above 50 K and its concentration steeply 623 increases, which is consistent with the Hall measurements 624 (Figure 2). Thus, we assume that we can calculate the diffusive 625 part of the Seebeck coefficient  $S_d$  separately in each of the two 626 temperature regions considering that two different types of free 627 carriers govern the electronic transport in the respective 628 regions. We used a simplified model derived by Herrings, 57,58 629 for moderately doped silicon where  $S_d$  is given by

$$S_{\rm d} = -\frac{k_{\rm B}}{e} \left[ \ln \left( \frac{n}{n_0} \right) + \frac{\Delta \varepsilon}{k_{\rm B} T} \right]$$
(3)

631 where  $\Delta \varepsilon \cong 2k_{\rm B}T$  is the energy of the electrons relative to the 632 edge of the conduction band,  $k_{\rm B}$  is the Boltzmann constant, 633 and *e* is the electron charge.  $n_0$  denotes the effective density of 634 states in the conduction band:

$$n_0 = 2 \left( \frac{2\pi m_{\rm d} k_{\rm B} T}{h^2} \right)^{3/2} \tag{4}$$

 $_{636}$  where  $m_{\rm d}$  is the density of states effective mass and h is the  $_{637}$  Planck constant.

Using an effective mass of  $m_d = 2.2m_0$  for the carriers 638 639 dominating at higher temperatures (80-300 K) for the pristine 640 sample,<sup>39</sup> we obtained a reasonable coincidence with the 641 experimental data (empty black circles vs black solid line in 642 Figure 13). To qualitatively describe the further decrease in S 643 with decreasing temperature, we had to use a smaller  $m_d$  value. 644 We obtained a best fit for  $m_d = 0.7m_0$  in the temperature range 645 of 10-60 K (full black circles vs black solid line in Figure 13). 646 In terms of the point defect picture, we suggest that the lighter 647 electrons are derived mostly from the p states of sulfur and d 648 states of Cu; the heavier electrons share the d states of Fe. This 649 simplified model works well also for the lightly Pd-doped 650 samples ( $Cu_{1-x}Pd_xFeS_2$  (x = 0.005, 0.01, 0.02). A comparison 651 of the experimental data and the calculated  $S_d$  for the 652 Cu<sub>0.99</sub>Pd<sub>0.01</sub>FeS<sub>2</sub> sample is also presented in Figure 13 (blue 653 solid line vs empty blue circles). We note that a similar model



Figure 13. Seebeck coefficient as a function of temperature for  $CuFeS_2$  and  $Cu_{0.99}Pd_{0.01}FeS_2$  samples. Full lines represent interpolated experimental courses. Symbols represent calculated values.

is inapplicable for the Cu<sub>0.9</sub>Pd<sub>0.1</sub>FeS<sub>2</sub> sample due to the strong 654 degeneration. Although the diffusive component  $S_d$  dominates 655 the total Seebeck coefficient in the samples with lower free- 656 carrier concentrations, one observes another distinct contri- 657 bution to the *S* values appearing at low temperatures between 658 20 and 30 K in the form of a shoulder in the S = f(T) 659 dependence (see Figure 12) for the Cu<sub>1-x</sub>Pd<sub>x</sub>FeS<sub>2</sub> samples (x 660 = 0, 0.005, 0.01). Excluding a phonon drag contribution, we 661 attribute this shoulder to a magnetic order-derived contribu- 662 tion (please compare with the discussion for the thermal and 663 magnetic properties).

### 4. CONCLUSIONS

In the present paper, we attempted to shed more light on the 665 "mysterious" properties of the antiferromagnetic semiconduc- 666 tor CuFeS<sub>2</sub>. Based on extensive experimental and DFT results, 667 we can summarize the conclusions into the following points: 668

- 1. Strictly stoichiometric CuFeS<sub>2</sub> shows a clear Fe-  $_{669}$  generated AFM order and an accordingly low electrical  $_{670}$  conductivity. However, the strict stoichiometry in the  $_{671}$  solid state can be achieved only through preparation  $_{672}$  from the melt with a slight overstoichiometry of Cu  $_{673}$  (e.g., Cu<sub>1.01</sub>Fe<sub>0.99</sub>S<sub>2</sub>), which relates to a low concen-  $_{674}$  tration of intrinsic point defects (IPDs).
- 2.  $CuFeS_2$  prepared from an exactly stoichiometric melt 676 tends to form IPDs, which is connected with the 677 appearance of FM and non-negligible electrical con- 678 ductivity. The most distinctive IPD is the antisite (AS) 679 defect, with Fe residing in the place of Cu,  $Fe_{Cu}$ , which 680 behaves as a donor. Furthermore, sulfur vacancies,  $V_{S}$ , 681 can play a role in influencing the CuFeS<sub>2</sub> properties. The 682 IPD concentration can be varied either by changing the 683 stoichiometry (e.g., Cu/Fe) or by extrinsic doping, as in 684 the present case. 685
- 3. We can distinguish between two types of FM in 686 otherwise AFM CuFeS<sub>2</sub> using exchange bias. The first 687 type is derived from IPD-induced FM defects coupled to 688 the AFM background of the matrix; the second is based 689 on an uncoupled FM due to the presence of extraneous 690 phases. 691
- 4. Although the exchange bias is usually connected with the 692 pinning of uncompensated spins on an AFM domain 693 surface, the high mobility suggests that IPD-based 694

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- 5. The comparatively high mobility of electrons in the
  AFM structure is connected with Cu d orbital/S p
  orbital-generated states in the vicinity of the Fermi level.
  These defect-generated states provide a narrow window
  for mobile electrons. The charge transport is also
  connected to a weak FM signal in the undoped CuFeS<sub>2</sub>.
- 6. We suggest that Fe<sub>Cu</sub>, V<sub>S</sub>, and their combination can 703 seed an FM order within charge transfer (CT) 704 fluctuations that are otherwise AFM in nature. The 705 critical temperatures for the FM order are determined to 706 be  $T_{\rm C1} \approx 120$  K,  $T_{\rm C2} \approx 55$  K, and  $T_{\rm C3} \approx 30$  K. Next to 707 IPD-induced Cu d orbital/S p orbital-generated states, 708 the Fe d orbital-generated states enhance the mobility of 709 electrons. The concentration of a lone V<sub>S</sub> is markedly 710 lower than the concentration of  $Fe_{Cu}$ . The above 711 conclusions are corroborated also by observation of 712 magnetic contributions in the temperature-dependent 713 thermal conductivity and Seebeck coefficient of samples. 714
- 715 7. The results indicate that intrinsic defect can significantly
  716 modify the properties of charge transfer compounds.
  717 The modification consists in the seeding of charge
  718 transfer nature by point defects
- 718 transfer nature by point defects.

# 719 ASSOCIATED CONTENT

### 720 Supporting Information

721 The Supporting Information is available free of charge at 722 https://pubs.acs.org/doi/10.1021/acs.jpcc.0c06490.

723 A detailed analysis of electrical resistivities (section A),

724 BoltzTrap calculation of Seebeck coefficient (section B),

Mössbauer spectroscopy analysis (section C), and
magnetic properties above room temperature (section
D) (PDF)

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#### Notes

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#### ABBREVIATIONS

AFM; antiferromagnetic; AS; antisite; CT; charge transfer; 767 DFT; density functional theory; DOS; density of states; IPD; 768 intrinsic point defect; FM; ferromagnetic; VRH; variable-range 769 hopping 770

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